'LS673

- **16-Bit Serial-In, Serial-Out Shift Register with 16-Bit Parallel-Out Storage Register**
- **Performs Serial-to-Parallel Conversion**

'LS674

- **16-Bit Parallel-In, Serial-Out Shift Register**
- **Performs Parallel-to-Serial Conversion**

description

SN54LS673, SN74LS673

The 'LS673 is a 16-bit shift register and a 16-bit storage register in a single 24-pin package. A three-state input/output (SER/Q15) port to the shift register allows serial entry and/or reading of data. The storage register is connected in a parallel data loop with the shift register and may be asynchronously cleared by taking the store-clear input low. The storage register may be parallel loaded with shift-register data to provide shift-register status via the parallel outputs. The shift register can be parallel loaded with the storage-register data upon command.

A high logic level at the chip-level ($\overline{CS}$) input disables both the shift-register clock and the storage register clock and places SER/Q15 in the high-impedance state. The store-clear function is not disabled by the chip select.

Caution must be exercised to prevent false clocking of either the shift register or the storage register via the chip-select input. The shift clock should be low during the low-to-high transition of chip select and the store clock should be low during the high-to-low transition of chip select.

SN54LS674, SN74LS674

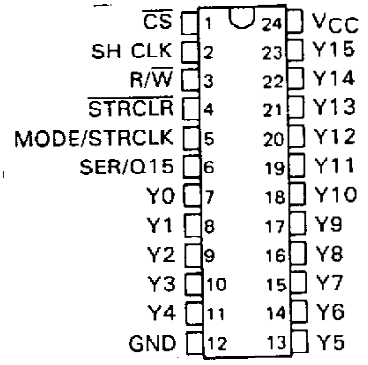
The 'LS674 is a 16-bit parallel-in, serial-out shift register. A three-state input/output (SER/Q15) port provides access for entering a serial data or reading the shift-register word in a recirculating loop.

The device has four basic modes of operation:

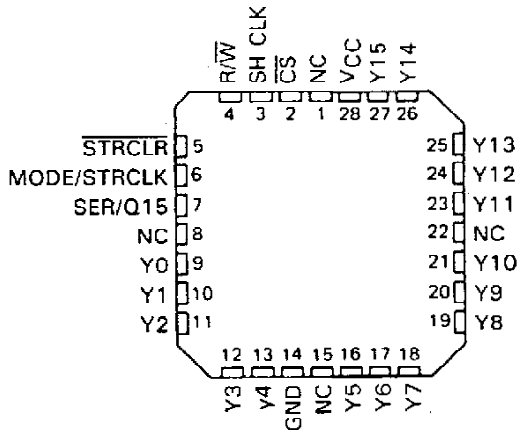
1) Hold (do nothing)
2) Write (serially via input/output)
3) Read (serially)
4) Load (parallel via data inputs)

Low-to high-level changes at the chip select input should be made only when the clock input is low to prevent false clocking.

SN54LS673 . . . J OR W PACKAGE
SN74LS673 . . . DW OR N PACKAGE
(TOP VIEW)

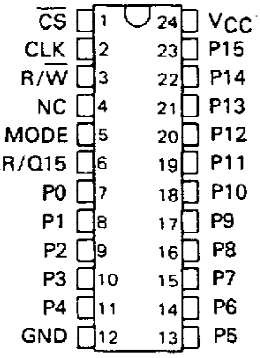


SN54LS673 . . . FK PACKAGE
(TOP VIEW)

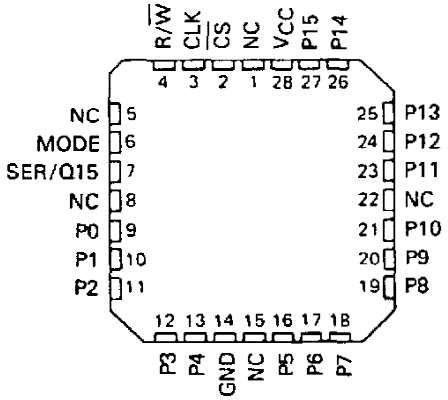


NC—No internal connection

SN54LS674 . . . J OR W PACKAGE
SN74LS674 . . . DW OR N PACKAGE
(TOP VIEW)



SN54LS674 . . . FK PACKAGE
(TOP VIEW)



'LS673
FUNCTION TABLE

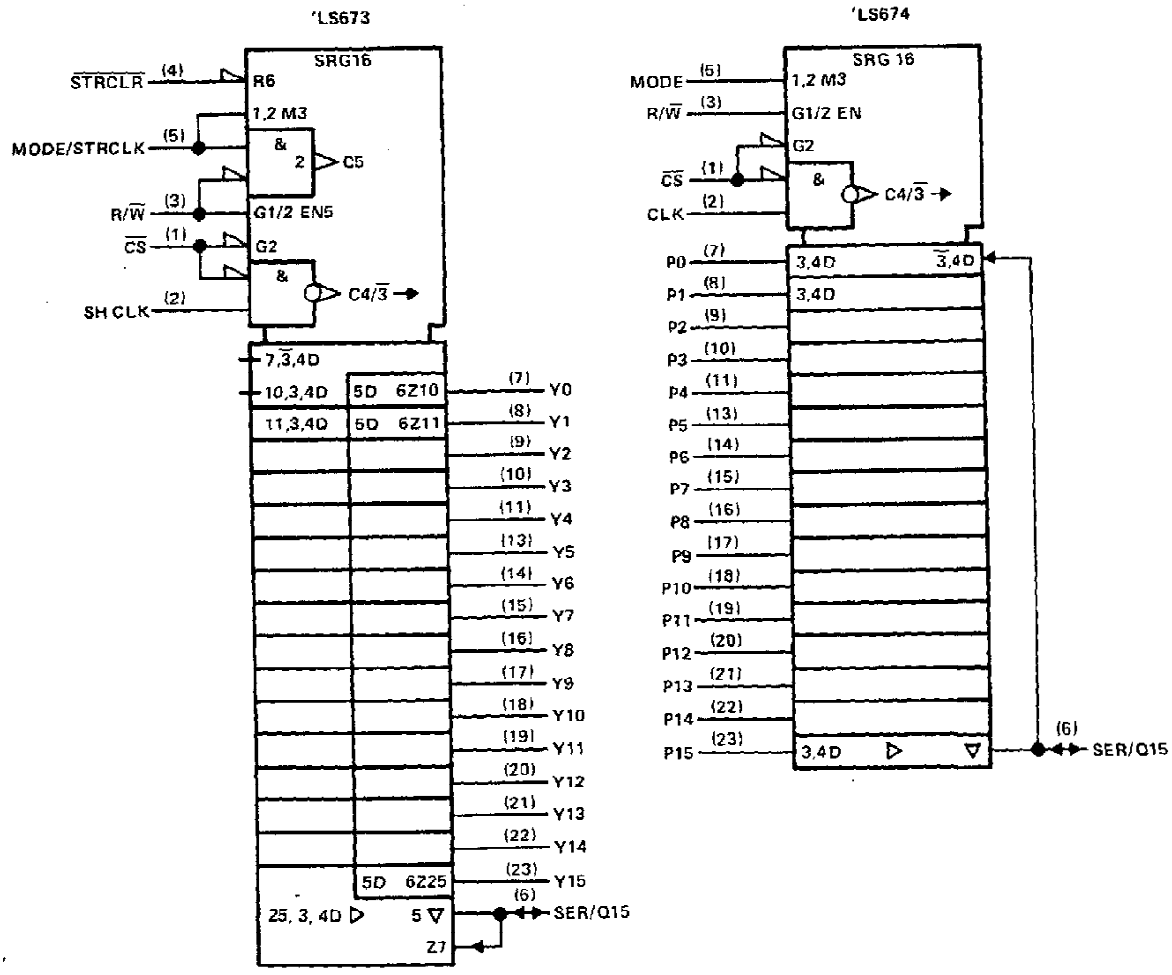
INPUTS					SER/ Q15	SHIFT REGISTER FUNCTIONS				STORAGE REGISTER FUNCTIONS	
$\overline{CS}$	R/$\overline{W}$	SH CLK	$\overline{STRCLR}$	MODE/ STRCLK		SHIFT	READ FROM SERIAL OUTPUT	WRITE INTO SERIAL INPUT	PARALLEL LOAD	CLEAR	LOAD
H	X	X	X	X	Z	NO	NO	NO	NO		NO
X	X	X	L	X						YES	
L	L	↓	X	X	Z	YES	NO	YES	NO		
L	H	X	X	X	Q15		YES	NO			NO
L	H	↓	X	L	Q14n	YES	YES	NO	NO		NO
L	H	↓	L	H	L	NO	YES		YES	YES	NO
L	H	↓	H	H	Y15n	NO	YES		YES	NO	NO
L	L	X	H	↑	Z		NO		NO	NO	YES

'LS674 FUNCTION TABLE

INPUTS				SER/ Q15	OPERATION
$\overline{CS}$	R/$\overline{W}$	MODE	CLK		
H	X	X	X	Z	Do nothing
L	L	X	↓	Z	Shift and write (serial load)
L	H	L	↓	Q14n	Shift and read
L	H	H	↓	P15	Parallel load

H = high level (steady state)
L = low level (steady state)
↑ = transition from low to high level
↓ = transition from high to low level
X = irrelevant (any input including transitions)
Z = high impedance, input mode
Q14n = content of 14th bit of the shift register before the most recent ↓ transition of the clock.
Q15 = present content of 15th bit of the shift register
Y15n = content of the 15th bit of the storage register before the most recent ↓ transition of the clock.
P15 = level of input P15

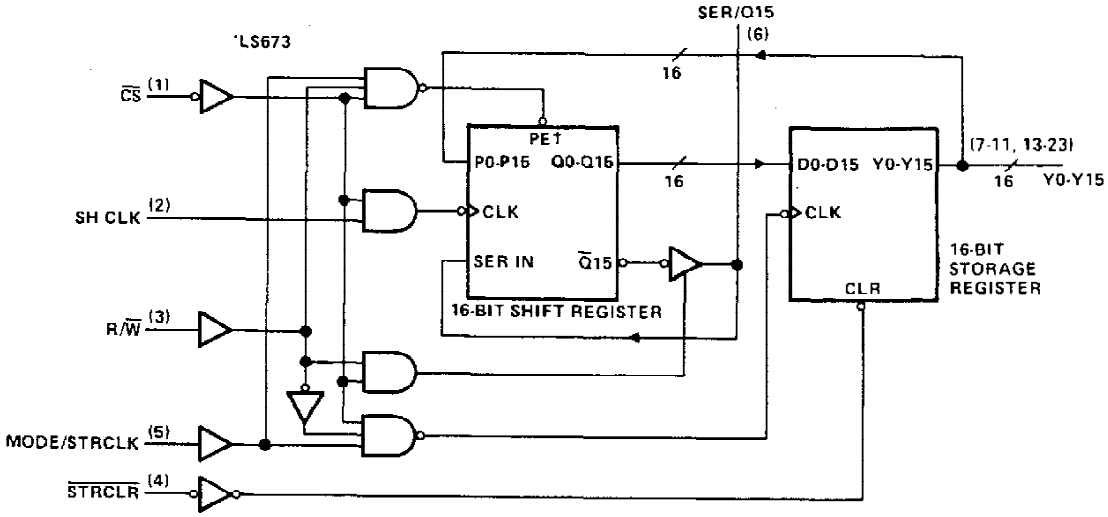
logic symbols†



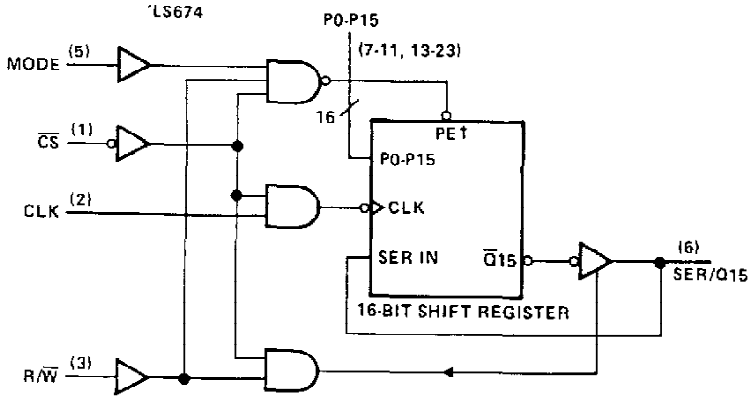
†These symbols are in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.
Pin numbers shown are for DW, J, N, and W packages.

functional block diagrams

SN54LS673, SN74LS673

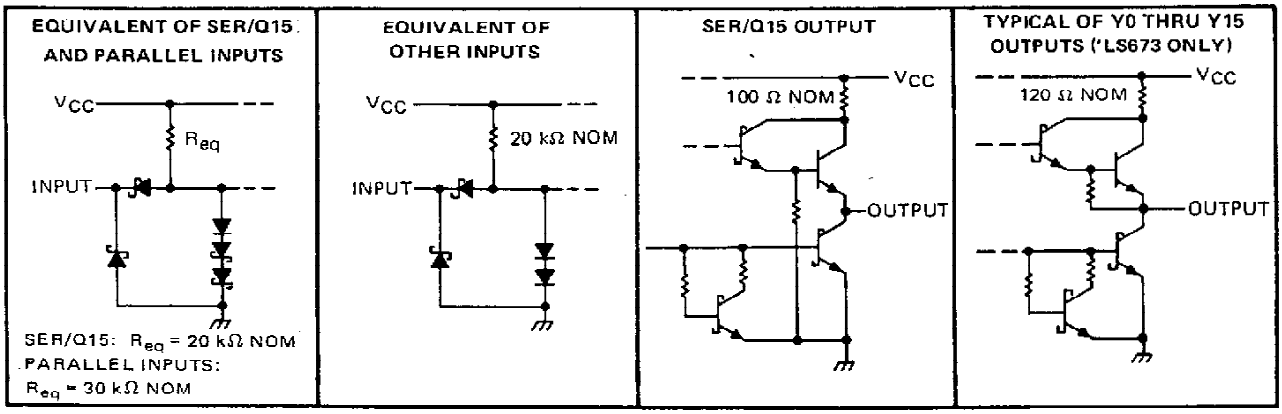


SN54LS674, SN74LS674



†When PE is active, data is synchronously parallel loaded into the shift registers from the 16 P inputs and no shifting takes place.
Pin numbers shown are for DW, J, N, and W packages.

schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage: SER/Q15 . . . . . 5.5 V
All others . . . . . 7 V
Off-state output voltage . . . . . 5.5 V
Operating free-air temperature range: SN54LS673, SN54LS674 . . . . . −55°C to 125°C
SN74LS673, SN74LS674 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

NOTE 1. Voltage values are with respect to network ground terminal.

recommended operating conditions

				SN54LS'			SN74LS'			UNIT
				MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage			4.5	5	5.5	4.75	5	5.25	V
I_{OH}	High-level output current	SER/Q15				−1			−2.6	mA
		Y0 thru Y15				−0.4			−0.4	
I_{OL}	Low-level output current	SER/Q15				12			24	mA
		Y0 thru Y15				4			8	
f_{clock}	Clock frequency			0		20	0		20	MHz
$t_{w(clock)}$	Width of clock input pulse			20			20			ns
$t_{w(clear)}$	Width of clear input pulse			20			20			ns
t_{su}	Setup time	SER/Q15		20			20			ns
		P0 thru P15		20			20			
		Mode		35			35			
		R/$\overline{W}$, $\overline{CS}$		35			35			
		SH CLK ↓ to Mode/STR CLK ↑ See Note 2		25			25			
t_h	Hold time	SER/Q15		0			0			ns
		P0 thru P15	'LS673	0			0			
			'LS674	5.0			5.0			
		Mode		0			0			
T_A	Operating free-air temperature			−55		125	0		70	°C

NOTE 2: This setup time ensures the storage register will see stable data from the shift register.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS†		SN54LS'			SN74LS'			UNIT
					MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IH}	High-level input voltage				2			2			V
V_{IL}	Low-level input voltage						0.7			0.8	V
V_{IK}	Input clamp voltage		V_{CC} = MIN,	I_I = −18 mA			−1.5			−1.5	V
V_{OH}	High-level output voltage	SER/Q15	V_{CC} = MIN,	V_{IH} = 2 V,	2.4	3.2		2.4	3.1		V
		Y0 thru Y15¶	V_{IL} = V_{IL}max,	I_{OH} = MAX	2.5	3.4		2.7	3.4		
V_{OL}	Low-level output voltage	SER/Q15	V_{CC} = MIN,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
			V_{IH} = 2 V,	I_{OL} = 24 mA					0.35	0.5	
		Y0 thru Y15¶	V_{IL} = V_{IL}max	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	
				I_{OL} = 8 mA					0.35	0.5	
I_{OZH}	Off-state output current, high-level voltage applied	SER/Q15	V_{CC} = MAX, V_{IL} = V_{IL}max,	V_{IH} = 2 V, V_O = 2.7 V			40			40	μA
I_{OZL}	Off-state output current, low-level voltage applied	SER/Q15	V_{CC} = MAX, V_{IL} = V_{IL}max,	V_{IH} = 2 V, V_O = 0.4 V			−0.4			−0.4	mA
I_I	Input current at maximum input voltage	SER/Q15	V_{CC} = MAX	V_I = 5.5 V			0.1			0.1	mA
		Others		V_I = 7 V			0.1			0.1	
I_{IH}	High-level input current	SER/Q15	V_{CC} = MAX,	V_I = 2.7 V			40			40	μA
		Others					20			20	
I_{IL}	Low-level input current		V_{CC} = MAX,	V_I = 0.4 V			−0.4			−0.4	mA
I_{OS}	Short-circuit output current§	SER/Q15	V_{CC} = MAX		−30		−130	−30		−130	mA
		Y0 thru Y15¶			−20		−100	−20		−100	
I_{CC}	Supply current	'LS673	V_{CC} = MAX			50	80		52	80	mA
		'LS674				25	40		25	40	

†For conditions shown as MIN or MAX use the appropriate value specified under recommended operating conditions.
‡All typical values are at V_{CC} = 5 V, T_A = 25°C.
§Not more than one output should be shorted at a time, and duration of the short circuit should not exceed one second.
¶'LS673 only.

switching characteristics, V_{CC} = 5 V, T_A = 25°C, see note 2

PARAMETER	'LS673		'LS674		TEST CONDITIONS	MIN	TYP	MAX	UNIT
	FROM	TO	FROM	TO					
f_{max}	SH CLK	SER/Q15	CLK	SER/Q15	R_L = 667 Ω, C_L = 45 pF	20	28		MHz
t_{PHL}	STRCLR	Y0 thru Y15			R_L = 2 kΩ, C_L = 15 pF		25	40	ns
t_{PLH}	MODE/ STRCLK	Y0 thru Y15					28	45	
t_{PHL}							30	45	
t_{PLH}	SH CLK	SER/Q15	CLK	SER/Q15	R_L = 667 Ω, C_L = 45 pF		21	33	ns
t_{PHL}							26	40	
t_{PZH}	$\overline{CS}$, R/$\overline{W}$	SER/Q15	$\overline{CS}$, R/$\overline{W}$	SER/Q15	R_L = 667 Ω, C_L = 45 pF		30	45	ns
t_{PZL}							30	45	
t_{PHZ}	$\overline{CS}$, R/$\overline{W}$	SER/Q15	$\overline{CS}$, R/$\overline{W}$	SER/Q15	R_L = 667 Ω, C_L = 5 pF		25	40	ns
t_{PLZ}							25	40	

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.